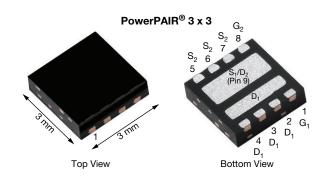


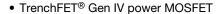
Vishay Siliconix

Dual N-Channel 30 V (D-S) MOSFET



PRODUCT SUMMARY					
V _{DS} (V)	30				
$R_{DS(on)}$ max. (Ω) at $V_{GS} = 10 \text{ V}$	0.00965				
$R_{DS(on)}$ max. (Ω) at $V_{GS} = 4.5 \text{ V}$	0.0145				
Q _g typ. (nC)	4				
I _D (A)	32.9 ^a				
Configuration	Dual				

FEATURES





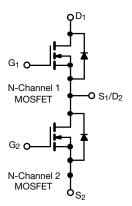
 High side and low side MOSFETs form optimized combination for 50 % duty cycle

COMPLIANT HALOGEN FREE

- • Optimized R_{DS} - Q_g and R_{DS} - Q_{gd} FOM elevates efficiency for high frequency switching
- 100 % R_a and UIS tested
- Material categorization: for definitions of compliance please see <u>www.vishay.com/doc?99912</u>

APPLICATIONS

- Synchronous buck
- DC/DC conversion
- Half bridge
- POL



ORDERING INFORMATION			
Package	PowerPAIR 3 x 3		
Lead (Pb)-free and halogen-free	SiZ342BDT-T1-GE3		

PARAMETER		SYMBOL	LIMIT	UNIT	
Drain-source voltage		V _{DS}	30	V	
Gate-source voltage		V _{GS}	+20 / -16		
Continuous drain current (T _J = 150 °C)	T _C = 25 °C		32.9		
	T _C = 70 °C		26.3		
	T _A = 25 °C	I _D	15.4 ^{b, c}		
	T _A = 70 °C		12.3 b, c		
Pulsed drain current (t = 100 μs)		I _{DM}	100	Α	
Continuous source current (MOSFET diode conduction)	T _C = 25 °C		13.9		
	T _A = 25 °C	I _S	3.1 b, c		
Single pulse avalanche current	. 0.1!!	I _{AS}	10		
Single pulse avalanche energy	L = 0.1 mH	E _{AS}	5	mJ	
Maximum power dissipation	T _C = 25 °C		16.7		
	T _C = 70 °C		10.7	١٨/	
	T _A = 25 °C	P _D	3.7 b, c	W	
	T _A = 70 °C		2.4 b, c		
Operating junction and storage temperature range		T _J , T _{stg}	-55 to +150		
Soldering recommendations (peak temperature)			260	⊸ °C	

Notes

a. $T_C = 25$ °C

b. Surface mounted on 1" x 1" FR4 board

c. t = 10 s



Vishay Siliconix

THERMAL RESISTANCE RATINGS						
PARAMETER		SYMBOL	TYPICAL	MAXIMUM	UNIT	
Maximum junction-to-ambient a, b	t ≤ 10 s	R_{thJA}	27	34	°C/W	
Maximum junction-to-case (drain)	Steady state	R_{thJC}	6	7.5		

Notes

- a. Surface mounted on 1" x 1" FR4 board
- b. Maximum under steady state conditions is 69 °C/W

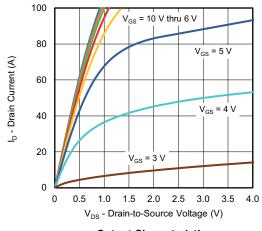
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static				•			
Drain-source breakdown voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	30	-	-	V	
Gate-source threshold voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1.1	-	2.4		
Gate-source leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = +20 \text{ V} / -16 \text{ V}$	-	-	± 100	nA	
Zava sata waltana disain awasat		$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}$	-	-	1	μА	
Zero gate voltage drain current	I _{DSS}	V _{DS} = 30 V, V _{GS} = 0 V, T _J = 55 °C	-	-	5		
Duning and the second of the s	Б	$V_{GS} = 10 \text{ V}, I_D = 10 \text{ A}$	-	0.0071	0.00965		
Drain-source on-state resistance ^a	R _{DS(on)}	$V_{GS} = 4.5 \text{ V}, I_D = 7 \text{ A}$	-	0.011	0.0145	Ω	
Forward transconductance a	9 _{fs}	$V_{DS} = 10 \text{ V}, I_D = 10 \text{ A}$	-	30	-	S	
Dynamic ^b							
Input capacitance	C _{iss}		-	550	-	pF	
Output capacitance	C _{oss}	V _{DS} = 15 V, V _{GS} = 0 V, f = 1 MHz	-	230	-		
Reverse transfer capacitance	C _{rss}		-	30	-		
C _{rss} /C _{iss} ratio			-	0.054	0.110		
		$V_{DS} = 15 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 15 \text{ A}$ $V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 15 \text{ A}$	-	8.4	12.6	nC	
Total gate charge	Q_g		-	4	6		
Gate-source charge	Q _{as}		-	2.2	-		
Gate-drain charge	Q _{ad}		-	1.0	-		
Gate resistance	Rq	f = 1 MHz	0.2	1	2	Ω	
Turn-on delay time	t _{d(on)}	V_{DD} = 15 V, R_L = 1.5 Ω , I_D \cong 10 A, V_{GEN} = 10 V, R_g = 1 Ω	-	8	20	-	
Rise time	t _r		-	6	12		
Turn-off delay time	t _{d(off)}		-	18	36		
Fall time	t _f		-	5	10		
Turn-on delay time	t _{d(on)}		-	15	25	ns	
Rise time	t _r	$V_{DD} = 15 \text{ V}, R_1 = 1.5 \Omega, I_D \cong 10 \text{ A},$	-	450	675	- - -	
Turn-off delay time	t _{d(off)}	$V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$	-	10	20		
Fall time	t _f		-	14	28		
Drain-source Body Diode Characterist	cs						
Continuous source-drain diode current	I _S	T _C = 25°C	-	-	13.9	_	
Pulse diode forward current	I _{SM}	-	-	-	100	Α	
Body diode voltage	V _{SD}	I _S = 8 A, V _{GS} = 0 V	-	0.83	1.2	V	
Body diode reverse recovery time	t _{rr}	5 . 45	-	21	42	ns	
Body diode reverse recovery charge	Q _{rr}	$I_F = 10 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s},$	-	11	22	nC	
Reverse recovery fall time	t _a	$T_J = 25 ^{\circ}C$	-	11	-	ns	
Reverse recovery rise time	t _b		-	10	_		

Notes

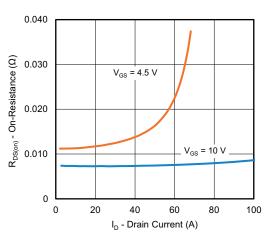
- a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%$
- b. Guaranteed by design, not subject to production testing

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

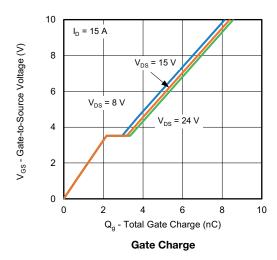


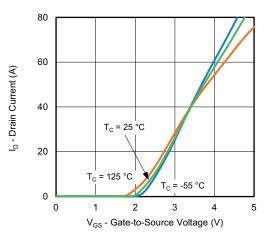


Output Characteristics

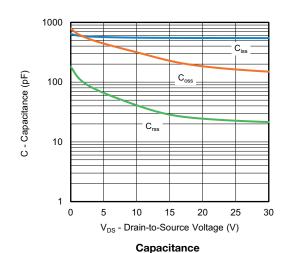


On-Resistance vs. Drain Current and Gate





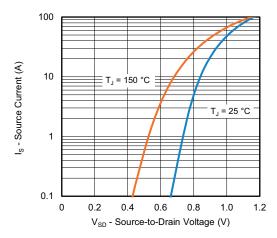
Transfer Characteristics



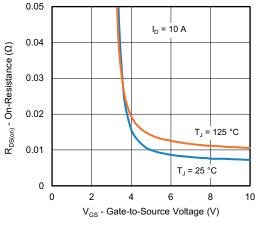
1.6 R_{DS(on)} - On-Resistance (Normalized) $V_{GS} = 10 \text{ V}$ 1.4 = 10A 1.2 V_{GS} = 4.5 V 1.0 8.0 0.6 -50 25 50 75 100 125 T_J - Junction Temperature (°C)

On-Resistance vs. Junction Temperature

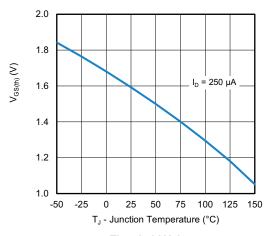




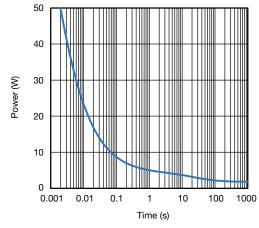
Source-Drain Diode Forward Voltage



On-Resistance vs. Gate-to-Source Voltage

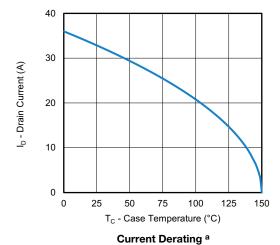


Threshold Voltage

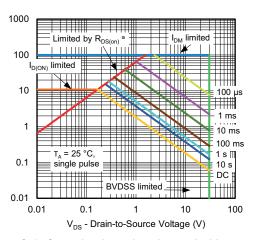


Single Pulse Power

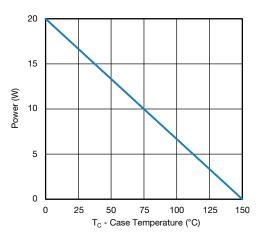


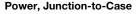


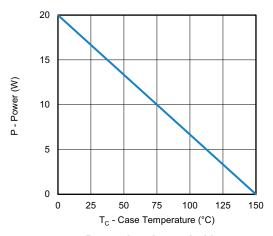




Safe Operating Area, Junction-to-Ambient





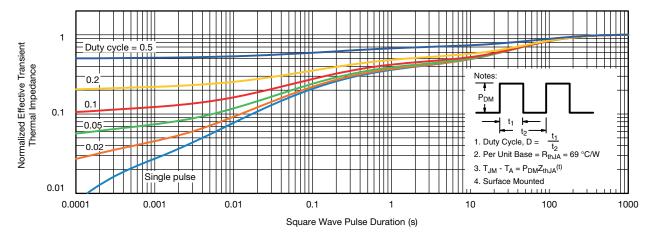


Power, Junction-to-Ambient

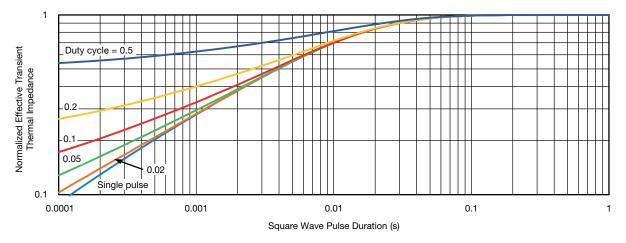
Notes

- a. The power dissipation P_D is based on T_J max. = 150 °C, using junction-to-ambient thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit
- b. V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified





Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

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